

<b>Notice of References Cited</b>	Application/Control No. 10/659,283	Applicant(s)/Patent Under Reexamination LIN, DHEI-JHAI	
	Examiner William M. Brewster	Art Unit 2823	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,078,377 A	06-2000	Tomono et al.	349/143
X	B	US-6,063,527 A	05-2000	Nishikawa et al.	430/7
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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